

# L6393

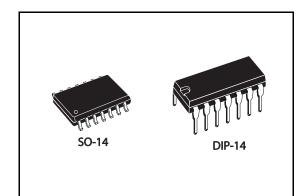
### Half-bridge gate driver

### Features

- High voltage rail up to 600 V
- dV/dt immunity ± 50 V/nsec in full temperature range
- Driver current capability:
  - 270 mA source,
  - 430 mA sink
- Switching times 75/35 nsec rise/fall with 1 nF load
- 3.3 V, 5 V CMOS/TTL inputs comparators with hysteresys
- Integrated bootstrap diode
- Uncommitted comparator
- Adjustable dead-time
- Compact and simplified layout
- Bill of material reduction
- Flexible, easy and fast design

## Application

Motor driver for home appliances, factory automation, industrial drives and fans. HID ballasts, power supply units.



## Description

The L6393 is a high-voltage device manufactured with the BCD "OFF-LINE" technology. It has a monolithic half-bridge gate driver for N-channel Power MOSFET or IGBT.

The high side (floating) section is designed to stand a voltage rail up to 600 V.

The logic inputs are CMOS/TTL compatible down to 3.3 V for easy of interfacing  $\mu$ C/DSP.

The IC embeds an uncommited comparator available for protections against over-current, over-temperature, etc.

Order codes	Package	Packaging
L6393	DIP-14	Tube
L6393D	SO-14	Tube
L6393D013TR	SO-14	Tape and reel

#### Table 1. Device summary

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## 1 Block diagram

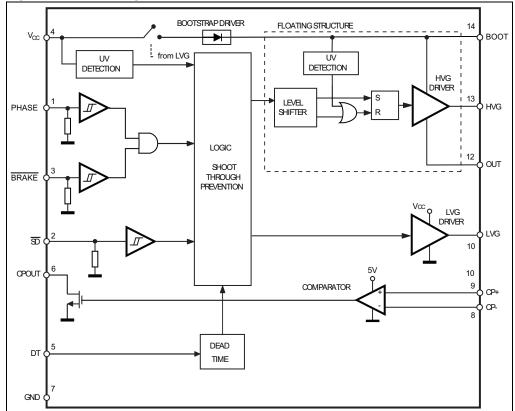
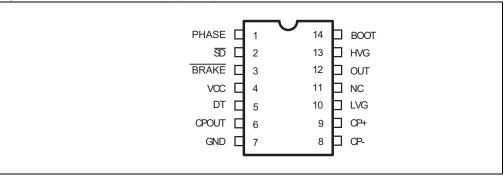


Figure 1. Block diagram



## 2 Pin connection

Figure 2.	Pin	connection	(top	view)
Figure 2.	гш	connection	(top	view)



### 2.1 Pin description

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Pin N#	Pin name	Туре	Function
1	PHASE	I	Driver logic input (active high)
2	SD (1)	I	Shut down input (active low)
3	BRAKE	I	Driver logic input (active low)
4	VCC	Р	Lower section supply voltage
5	DT	I	Dead time setting
6	CPOUT	0	Comparator output (open drain)
7	GND	Р	Ground
8	CP-	I	Comparator negative input
9	CP+	I	Comparator positive input
10	LVG <sup>(1)</sup>	0	Low side driver output
11	NC		Not connected
12	OUT	Р	High side (floating) common voltage
13	HVG <sup>(1)</sup>	0	High side driver output
14	BOOT	Р	Bootstrapped supply voltage

Table 2. Pin description

1. The circuit guarantees less than 1 V on the LVG and HVG pins (@ Isink = 10 mA), with V<sub>CC</sub> > 3 V. This allows omitting the "bleeder" resistor connected between the gate and the source of the external MOSFET normally used to hold the pin low; the gate driver assures low impedance also in SD condition.

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### 3 Truth table

Table 3.	Truth table

INPUTS			Ουτι	PUTS
SD	PHASE	BRAKE	LVG	HVG
L	Х	Х	L	L
Н	L	L	Н	L
Н	L	Н	Н	L
Н	Н	L	Н	L
Н	Н	Н	L	Н

#### Note: X: don't care

In the L6393 IC the two input signals PHASE and BRAKE are fed into an AND logic port and the resulting signal is in phase with the high side output HVG and in opposition of phase with the low side output LVG. This means that if BRAKE is kept to high level, the PHASE signal drives the half-bridge in phase with the HVG output and in opposition of phase with the LVG output. If BRAKE is set to low level the low side output LVG is always ON and the high side output HVG is always OFF, whatever the PHASE signal. This kind of logic interface provides the possibility to control the power stages using the PHASE signal to select the current direction in the bridge and the BRAKE signal to perform current slow decay on the low sides.

From the point of view of the logic operations the two signals PHASE and BRAKE are completely equivalent, that means the two signals can be exchanged without any change in the behavior on the resulting output signals (see the Block Diagram in Fig.1).

Note: the dead time between the turn OFF of one power switch and the turn ON of the other power switch is defined by the resistor connected between DT pin and the ground.

## 4 Electrical data

## 4.1 Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>out</sub>	Output voltage	$V_{boot}$ - 21 to $V_{boot}$ + 0.3	V
V <sub>cc</sub>	Supply voltage	- 0.3 to + 21	V
V <sub>cp-</sub>	Comparator negative input voltage	-0.3 to V <sub>CC</sub> + 0.3	V
$V_{cp+}$	Comparator positive input voltage	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>boot</sub>	Floating supply voltage	V <sub>CC</sub> - 0.3 to 620	V
V <sub>hvg</sub>	High side gate output voltage output voltage	$V_{out}$ - 0.3 to $V_{boot}$ + 0.3	v
V <sub>Ivg</sub>	High side gate output voltage output voltage	-0.3 to V <sub>cc</sub> +0.3	V
Vi	Logic input voltage	-0.3 to 15	V
V <sub>cpout</sub>	Open drain voltage	-0.3 to 15	V
dV <sub>out</sub> /dt	Allowed output slew rate	50	V/ns
P <sub>tot</sub>	Total power dissipation ( $T_A = 85 \ ^{\circ}C$ )	TBD	mW
Τ <sub>J</sub>	Junction temperature	150	°C
T <sub>stg</sub>	Storage temperature	-50 to 150	°C

#### Table 4. Absolute maximum rating

Note: ESD immunity for pins 12, 13 and 14 is guaranteed up to V (Human Body Model)

### 4.2 Thermal data

#### Table 5.Thermal data

Symbol	Parameter	SO-14	DIP-14	Unit
R <sub>th(JA)</sub>	Thermal resistance junction to ambient max.	165	100	°C/W

## 4.3 Recommended operating conditions

Table 6.	Recommended	operating	conditions
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Symbol	Pin	Parameter	Test condition	Min	Max	Unit
V <sub>out</sub>	12	Output voltage (1)			580	V
V <sub>BS</sub> <sup>(2)</sup>	14	Floating supply voltage <sup>(1)</sup>		TBD	TBD	V
f <sub>sw</sub>		Switching frequency	HVG, LVG load C <sub>L</sub> = 1 nF		800	kHz
V <sub>cc</sub>	4	Supply Voltage		TBD	TBD	V
Tj		Junction Temperature		40	125	°C

1. If the condition TBD V < V<sub>boot</sub> - V<sub>out</sub> < TBD V and V<sub>boot</sub> < TBD V are guaranteed, V<sub>out</sub> can range from TBD V to 580 V

2.  $V_{BS} = V_{boot} - V_{out}$ 



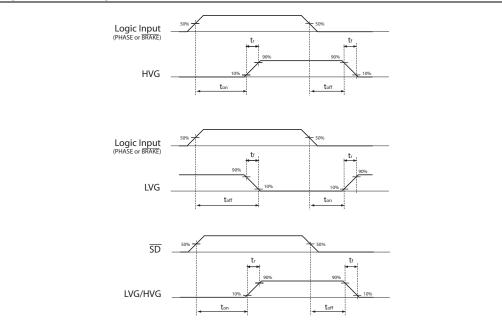
## 5 Electrical characteristics

## 5.1 AC operation

able 7. AC operation electrical characteristics ( $V_{CC} = 15 V$ , $I_J = +25 C$ )							
Symbol	Pin	Parameter	Test condition	Min	Тур	Max	Unit
AC opera	tion				-		
t <sub>on</sub>	1,3 vs	High/low side driver turn- on propagation delay	V <sub>out</sub> = 0 V		125		ns
t <sub>off</sub>	10, 13	High/low side driver turn- off propagation delay	$V_{boot} = V_{cc}$ $C_L = 1 nF$		125		ns
t <sub>sd</sub>	2 vs 10, 13	Shut down to high/low side propagation delay	V <sub>i</sub> = 0 to 3.3 V see <i>Figure 3 on page 9</i>		125		ns
MT		Delay matching, HS & LS turn-ON/OFF				40	ns
dt	5	Dead time setting range	$\begin{split} & R_{dt} = 0,  C_{L} = 1 nF,  C_{DT} = 100 nF \\ & R_{dt} = 37 k\Omega,  C_{L} = 1 nF,  C_{DT} = 100 nF \\ & R_{dt} = 136 k\Omega,  C_{L} = 1 nF,  C_{DT} = 100 nF \\ & R_{dt} = 260 k\Omega,  C_{L} = 1 nF,  C_{DT} = 100 nF \end{split}$		0.15 0.5 1.5 2.8		μs μs μs μs
MDT		Matching dead time	$\begin{split} & R_{dt} = 0 \; \Omega; \; C_{L} = 1 \; nF; \; C_{DT} = 100 \; nF \\ & R_{dt} = 37 \; k\Omega; C_{L} = 1 \; nF; C_{DT} = 100 \; nF \\ & R_{d} = 136 \; k\Omega; C_{L} = 1 \; nF; C_{DT} = 100 \; nF \\ & R_{dt} = 260 \; k\Omega; C_{L} = 1 \; nF; C_{DT} = 100 \; nF \end{split}$			60 TBD TBD TBD	ns ns ns ns
t <sub>r</sub>	10,	Rise time	C <sub>L</sub> = 1000 pF		75		ns
t <sub>f</sub>	13	Fall time	C <sub>L</sub> = 1000 pF		35		ns

#### Table 7. AC operation electrical characteristics ( $V_{CC} = 15 \text{ V}, T_{J} = +25 \text{ °C}$ )

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#### Figure 3. Timing



## 5.2 DC operation

Symbol	Pin	Parameter	Test condition	Min	Тур	Мах	Unit
Low supply	v voltag	e section					
V <sub>cc_hys</sub>		V <sub>cc</sub> UV hysteresis		600	1500		mV
$V_{cc\_thON}$		V <sub>cc</sub> UV Turn ON threshold			9.5		V
$V_{cc\_thOFF}$		V <sub>cc</sub> UV Turn OFF threshold			8.0		V
I <sub>qccu</sub>	4	Undervoltage quiescent supply current	$V_{CC} = 8 V$ $\overline{SD} = 5 V; PHASE and$ $\overline{BRAKE} = GND;$ $R_{DT} = 0 \Omega;$ $CP + = GND; CP - = 0.5 V$		110	150	μA
I <sub>qcc</sub>		Quiescent current	$V_{CC} = 15 V$ $\overline{SD} = 5 V; PHASE and$ $\overline{BRAKE} = GND;$ $R_{DT} = 0 \Omega;$ $CP + = GND; CP - = 0.5 V$		600	1000	μA
Bootstrapp	ed sup	ply voltage section					
V <sub>BS_hys</sub>		V <sub>BS</sub> UV hysteresis		600	1000		mV
$V_{BS\_thON}$		V <sub>BS</sub> UV turn ON Threshold			9.1		V
$V_{BS_{thOFF}}$		V <sub>BS</sub> UV turn OFF Threshold			8.1		V
I <sub>QBSU</sub>	14	Undervoltage V <sub>boot</sub> quiescent current	$V_{BS} = 7 V$ $\overline{SD} = 5 V; PHASE and$ $\overline{BRAKE} = 5 V;$ $R_{DT} = 0 \Omega;$ $CP + = GND; CP - = 0.5 V$		60	110	μA
I <sub>QBS</sub>		V <sub>boot</sub> quiescent current	$V_{BS} = 15 V$ SD = 5 V; PHASE and BRAKE = 5 V; $R_{DT} = 0 \Omega;$ CP + = GND; CP - = 0.5 V		140	210	μΑ
I <sub>LK</sub>		High voltage leakage current	$V_{hvg} = V_{out} = V_{boot} = 600 V$			10	μA
R <sub>dson</sub>		Bootstrap driver on resistance <sup>(1)</sup>	LVG ON		120		Ω

Table 8.DC opereation electrical characteristics ( $V_{CC} = 15 V$ ;  $T_J = +25 °C$ )

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Symbol	Pin	Parameter	Test condition	Min	Тур	Max	Unit
Driving buffers section							
I <sub>so</sub>	10, 13	High/low side source short circuit current	$V_{IN} = V_{ih} (t_p < 10 \ \mu s)$		270		mA
I <sub>si</sub>	10, 13	High/low side sink short circuit current	$V_{IN} = V_{il} (tp < 10 \ \mu s)$		430		mA
Logic input	ts						
V <sub>il</sub>	1, 2, 3	Low level logic threshold voltage				0.83	V
V <sub>ih</sub>		High level logic threshold voltage		2.21			V
I <sub>PHASEh</sub>	1	PHASE logic "1" input bias current	PHASE = 15 V		175	260	μ <b>A</b>
I <sub>PHASEI</sub>		PHASE logic "0" input bias current	PHASE = 0 V			1	μA
I <sub>BRAKEh</sub>	- 3	BRAKE logic "1" input bias current	BRAKE = 15 V		175	260	μA
I <sub>BRAKEI</sub>		BRAKE logic "0" input bias current	BRAKE = 0 V			1	μA
I <sub>SDh</sub>	2	SD logic "1" input bias current	<u>SD</u> = 15 V		30	100	μA
I <sub>SDI</sub>		SD logic "0" input bias current	$\overline{SD} = 0 V$			1	μA

DC opereation electrical characteristics (V<sub>CC</sub> = 15 V; T<sub>J</sub> = +25 °C) (continued) Table 8.

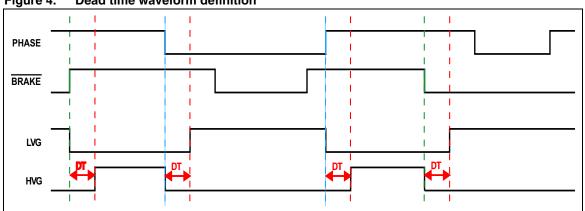
1.  $R_{DSon}$  is tested in the following way:  $R_{DSon} = [(V_{CC} - V_{CBOOT1}) - (V_{CC} - V_{CBOOT2})] / [I_1(V_{CC}, V_{CBOOT1}) - I_2(V_{CC}, V_{CBOOT2})]$ where  $I_1$  is pin 14 current when  $V_{CBOOT} = V_{CBOOT1}$ ,  $I_2$  when  $V_{CBOOT2}$ .

#### Table 9. Sense comparator

Symbol	Pin	Parameter	Test conditions	Min	Тур	Max	Unit
V <sub>io</sub>	8, 9	Input offset voltage			±10	TBD	mV
I <sub>ib</sub>		Input bias current				1	μA
V <sub>ol</sub>	6	Open drain low level Output voltage	I <sub>od</sub> = - 3 mA			0.5	V
t <sub>d_comp</sub>		Comparator delay	$C_{POUT}$ pulled to 5 V through 100k $\Omega$ resistor		110	210	ns
SR	6	Slew rate	$C_L$ = 180 nF, $R_{pu}$ = 5 k $\Omega$		TBD		V/µs



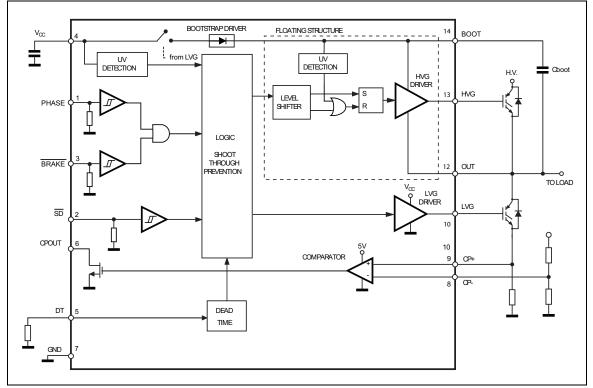
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### Figure 4. Dead time waveform definition



## 7 Typical application diagram



#### Figure 5. Application diagram



### 8 Bootstrap driver

A bootstrap circuitry is needed to supply the high voltage section. This function is normally accomplished by a high voltage fast recovery diode (*Figure 6.a*). In the L6393 a patented integrated structure replaces the external diode. It is realized by a high voltage DMOS, driven synchronously with the low side driver (LVG), with diode in series, as shown in *Figure 6.b*.

An internal charge pump (Figure 6.b) provides the DMOS driving voltage.

The diode connected in series to the DMOS has been added to avoid undesirable turn on of it.

### 8.1 C<sub>BOOT</sub> selection and charging

To choose the proper  $C_{BOOT}$  value the external MOS can be seen as an equivalent capacitor. This capacitor  $C_{EXT}$  is related to the MOS total gate charge:

$$C_{EXT} = \frac{Q_{gate}}{V_{gate}}$$

The ratio between the capacitors  $C_{\text{EXT}}$  and  $C_{\text{BOOT}}$  is proportional to the cyclical voltage loss. It has to be:

#### C<sub>BOOT</sub> >>> C<sub>EXT</sub>

e.g.: if  $Q_{gate}$  is 30nC and  $V_{gate}$  is 10 V,  $C_{EXT}$  is 3 nF. With  $C_{BOOT}$  = 100 nF the drop would be 300 mV.

If HVG has to be supplied for a long time, the C<sub>BOOT</sub> selection has to take into account also the leakage and quiescent losses.

e.g.: HVG steady state consumption is lower than 200  $\mu$ A, so if HVG T<sub>ON</sub> is 5 ms, C<sub>BOOT</sub> has to supply 1  $\mu$ C to C<sub>EXT</sub>. This charge on a 1  $\mu$ F capacitor means a voltage drop of 1 V.

The internal bootstrap driver gives a great advantage: the external fast recovery diode can be avoided (it usually has great leakage current).

This structure can work only if  $V_{OUT}$  is close to GND (or lower) and in the meanwhile the LVG is on. The charging time ( $T_{charge}$ ) of the  $C_{BOOT}$  is the time in which both conditions are fulfilled and it has to be long enough to charge the capacitor.

The bootstrap driver introduces a voltage drop due to the DMOS  $R_{DSon}$  (typical value: 120  $\Omega$ ). At low frequency this drop can be neglected. Anyway increasing the frequency it must be taken in to account.

The following equation is useful to compute the drop on the bootstrap DMOS:

$$V_{drop} = I_{charge}R_{dson} \rightarrow V_{drop} = \frac{Q_{gate}}{T_{charge}}R_{dson}$$

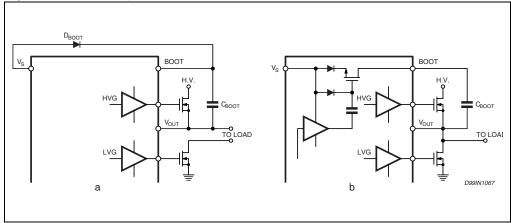
where  $Q_{gate}$  is the gate charge of the external power MOS,  $R_{DSon}$  is the on resistance of the bootstrap DMOS, and  $T_{charge}$  is the charging time of the bootstrap capacitor.

For example: using a power MOS with a total gate charge of 30 nC the drop on the bootstrap DMOS is about 1 V, if the  $T_{charge}$  is 5  $\mu$ s. In fact:

$$V_{drop} = \frac{30nC}{5\mu s} \cdot 120\Omega \sim 0.7V$$

 $V_{drop}$  has to be taken into account when the voltage drop on  $C_{BOOT}$  is calculated: if this drop is too high, or the circuit topology doesn't allow a sufficient charging time, an external diode can be used.

Figure 6. Bootstrap driver





## 9 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



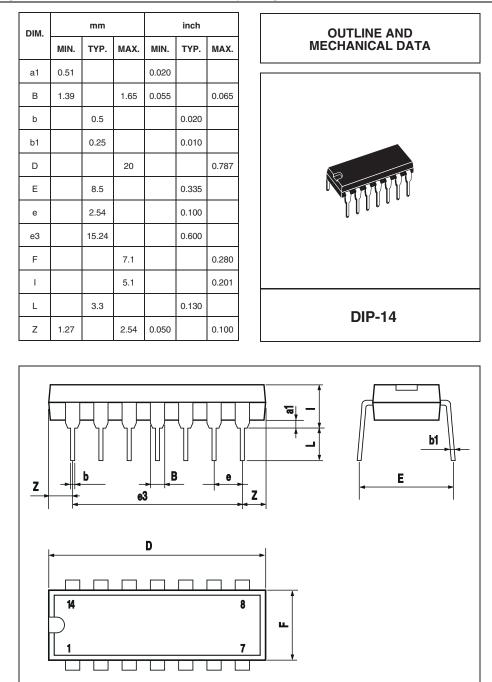


Figure 7. DIP-14 mechanical data and package dimensions



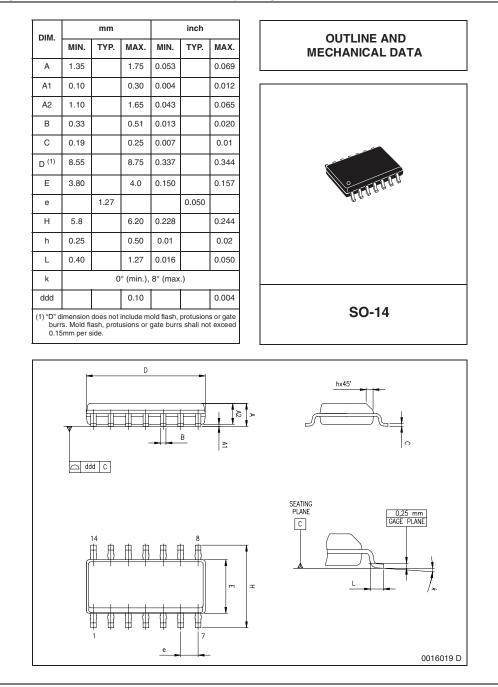


Figure 8. SO-14 mechanical data and package dimensions

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## 10 Revision history

#### Table 10.Document revision history

Date	Revision	Changes
03-Mar-2008	1	Initial release



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